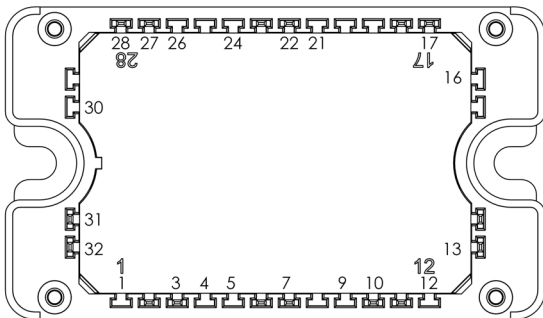
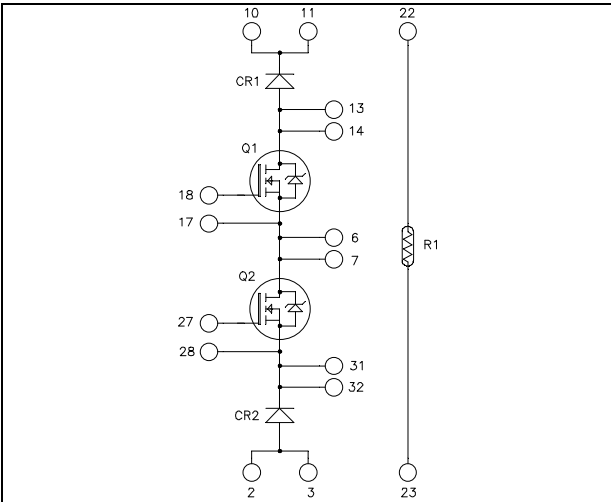


## Boost buck chopper MOSFET Power Module

$V_{DSS} = 600V$   
 $R_{DSon} = 24m\Omega \text{ max @ } T_j = 25^\circ C$   
 $I_D = 95A \text{ @ } T_c = 25^\circ C$



All multiple inputs and outputs must be shorted together  
 Example: 10/11 ; 13/14 ; 6/7 ...

### Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

### Features

- CoolMOS™
  - Ultra low  $R_{DSon}$
  - Low Miller capacitance
  - Ultra low gate charge
  - Avalanche energy rated
  - Very rugged
- Kelvin source for easy drive
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

### Absolute maximum ratings (per CoolMOS)

Symbol	Parameter	Max ratings	Unit
$V_{DSS}$	Drain - Source Breakdown Voltage	600	V
$I_D$	Continuous Drain Current	$T_c = 25^\circ C$	95
		$T_c = 80^\circ C$	70
$I_{DM}$	Pulsed Drain current	260	A
$V_{GS}$	Gate - Source Voltage	$\pm 20$	V
$R_{DSon}$	Drain - Source ON Resistance	24	$m\Omega$
$P_D$	Maximum Power Dissipation	$T_c = 25^\circ C$	462
$I_{AR}$	Avalanche current (repetitive and non repetitive)	15	A
$E_{AR}$	Repetitive Avalanche Energy	3	mJ
$E_{AS}$	Single Pulse Avalanche Energy	1900	

**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

**All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified**

**Electrical Characteristics** (per CoolMOS)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 600V			350	μA
		T <sub>j</sub> = 25°C				
		V <sub>GS</sub> = 0V, V <sub>DS</sub> = 600V			600	
R <sub>DS(on)</sub>	Drain – Source on Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 47.5A			24	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 5mA	2.1	3	3.9	V
I <sub>GSS</sub>	Gate – Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0V			200	nA

**Dynamic Characteristics** (per CoolMOS)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V ; V <sub>DS</sub> = 25V f = 1MHz		14.4		nF	
C <sub>oss</sub>	Output Capacitance				17		
Q <sub>g</sub>	Total gate Charge	V <sub>GS</sub> = 10V V <sub>Bus</sub> = 300V I <sub>D</sub> = 95A		300		nC	
Q <sub>gs</sub>	Gate – Source Charge				68		
Q <sub>gd</sub>	Gate – Drain Charge				102		
T <sub>d(on)</sub>	Turn-on Delay Time	<b>Inductive Switching (125°C)</b> V <sub>GS</sub> = 10V V <sub>Bus</sub> = 400V I <sub>D</sub> = 95A R <sub>G</sub> = 2.5Ω		21		ns	
T <sub>r</sub>	Rise Time				30		
T <sub>d(off)</sub>	Turn-off Delay Time				100		
T <sub>f</sub>	Fall Time				45		
E <sub>on</sub>	Turn-on Switching Energy	<b>Inductive switching @ 25°C</b> V <sub>GS</sub> = 10V ; V <sub>Bus</sub> = 400V I <sub>D</sub> = 95A ; R <sub>G</sub> = 2.5Ω		1350		μJ	
E <sub>off</sub>	Turn-off Switching Energy				1040		
E <sub>on</sub>	Turn-on Switching Energy	<b>Inductive switching @ 125°C</b> V <sub>GS</sub> = 10V ; V <sub>Bus</sub> = 400V I <sub>D</sub> = 95A ; R <sub>G</sub> = 2.5Ω		2200		μJ	
E <sub>off</sub>	Turn-off Switching Energy				1270		

**Chopper diode ratings and characteristics** (per diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage		600			V	
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> = 600V	T <sub>j</sub> = 25°C		500	μA	
			T <sub>j</sub> = 125°C		1000		
I <sub>F</sub>	DC Forward Current	T <sub>c</sub> = 80°C		120		A	
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 120A	T <sub>j</sub> = 25°C		1.6	1.8	V
		I <sub>F</sub> = 240A			1.9		
		I <sub>F</sub> = 120A	T <sub>j</sub> = 125°C		1.4		
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 120A V <sub>R</sub> = 400V di/dt = 400A/μs	T <sub>j</sub> = 25°C		130	ns	
			T <sub>j</sub> = 125°C		170		
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 120A V <sub>R</sub> = 400V di/dt = 400A/μs	T <sub>j</sub> = 25°C		440	nC	
			T <sub>j</sub> = 125°C		1840		

## Thermal and package characteristics

Symbol	Characteristic	Min	Typ	Max	Unit	
R <sub>thJC</sub>	Junction to Case Thermal Resistance	Per CoolMOS		0.27	°C/W	
		Per diode		0.46		
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000			V	
T <sub>J</sub>	Operating junction temperature range	-40		150	°C	
T <sub>STG</sub>	Storage Temperature Range	-40		125		
T <sub>C</sub>	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

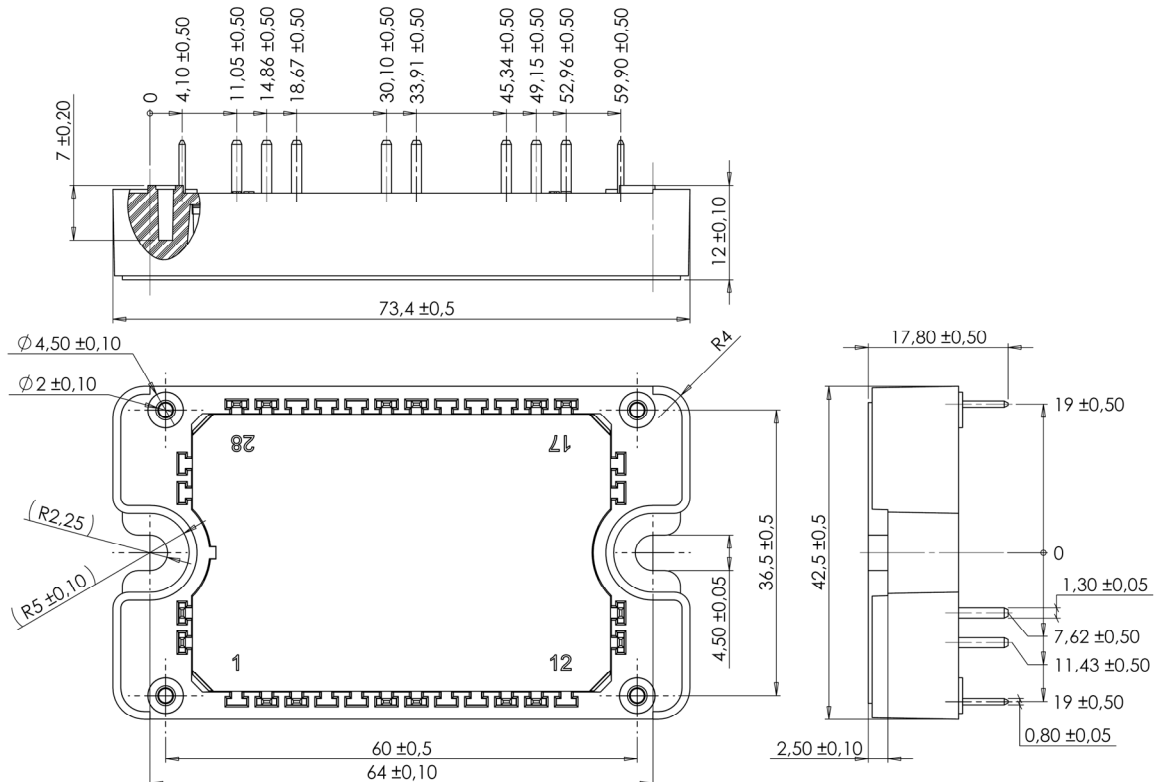
## Temperature sensor NTC

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		22		kΩ
ΔR <sub>25</sub> /R <sub>25</sub>	Resistance tolerance			5	%
ΔB/B	Beta tolerance			3	
B <sub>25/100</sub>	T <sub>25</sub> = 298.16 K		3980		K

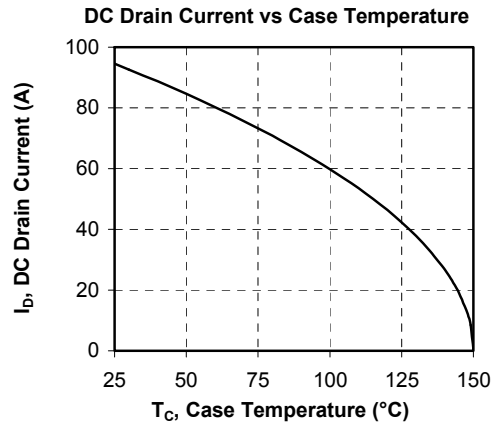
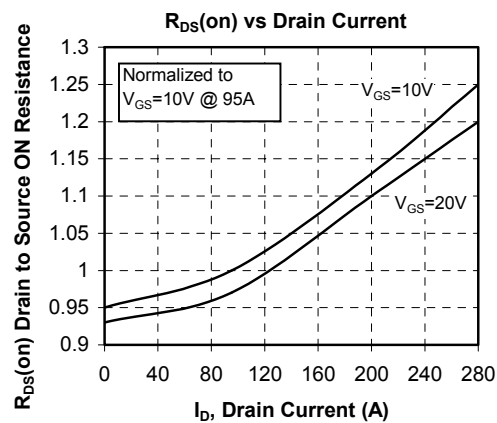
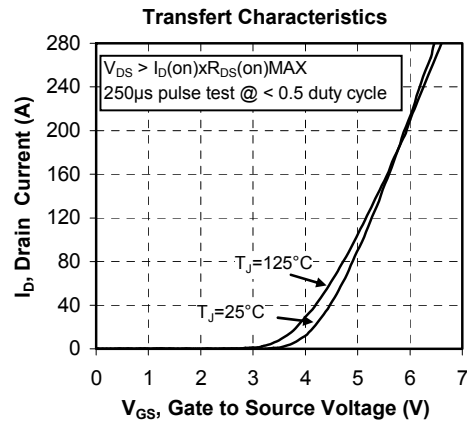
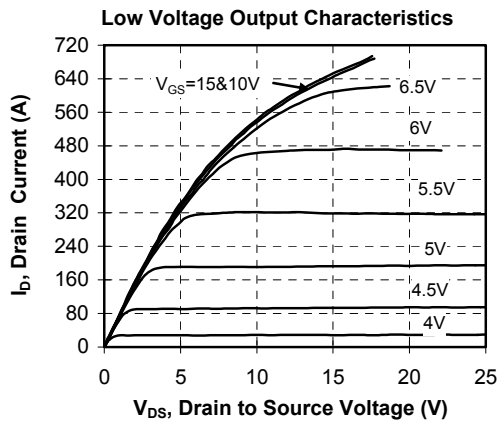
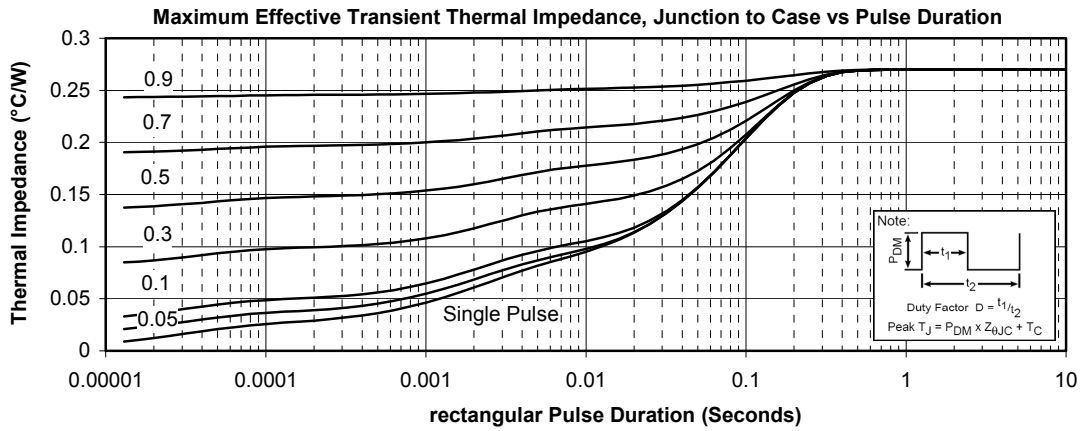
$$R_T = \frac{R_{25}}{\exp \left[ B_{25/100} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$

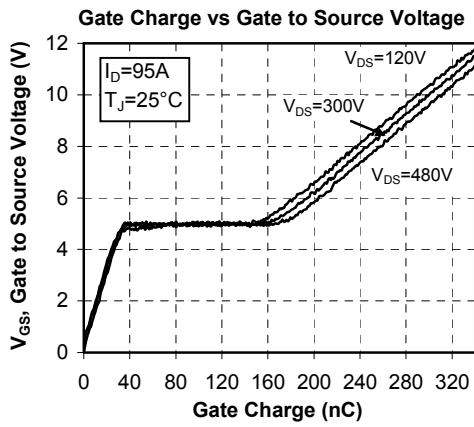
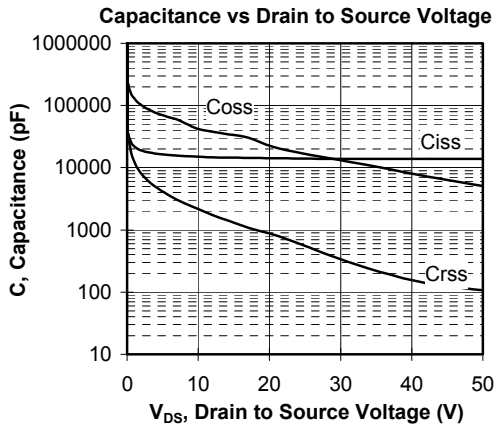
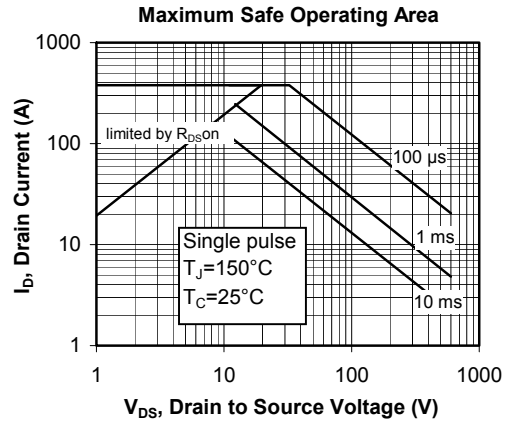
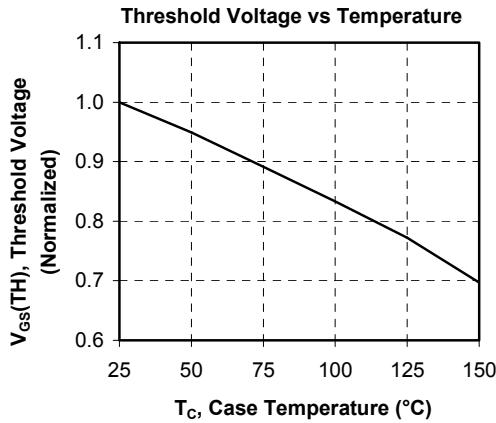
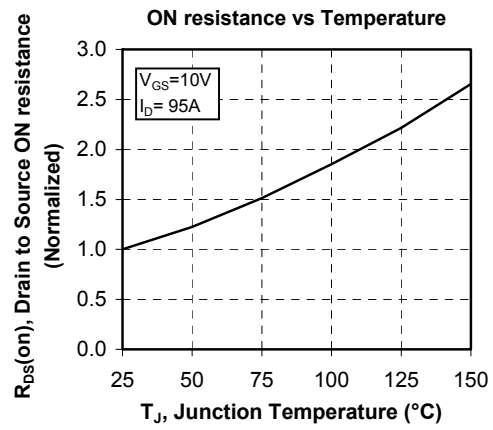
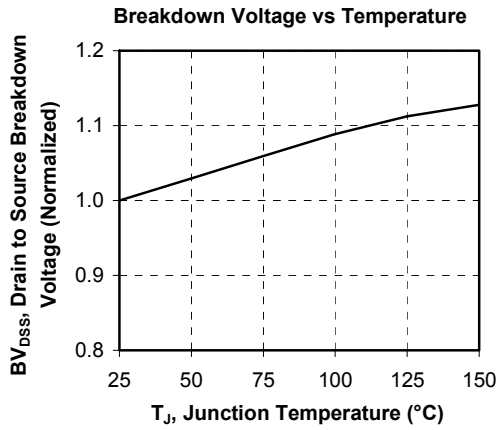
T: Thermistor temperature  
 R<sub>T</sub>: Thermistor value at T

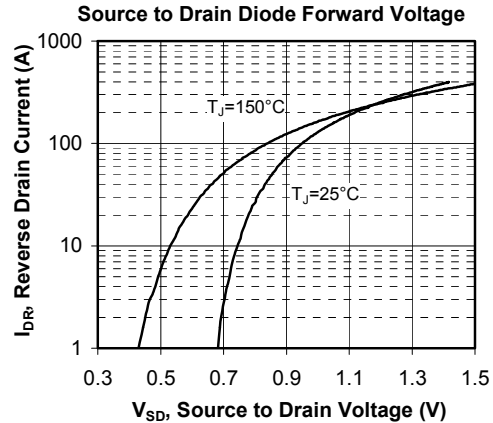
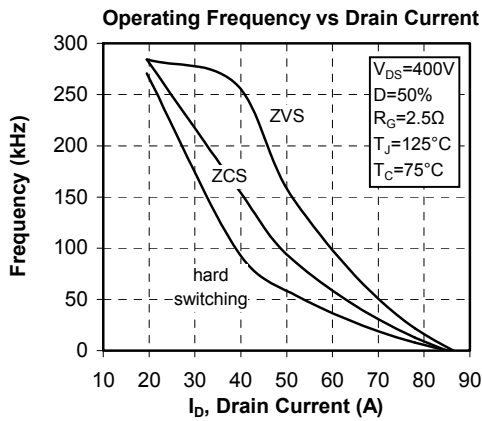
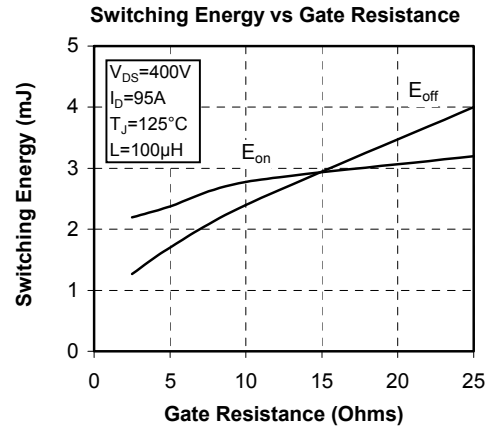
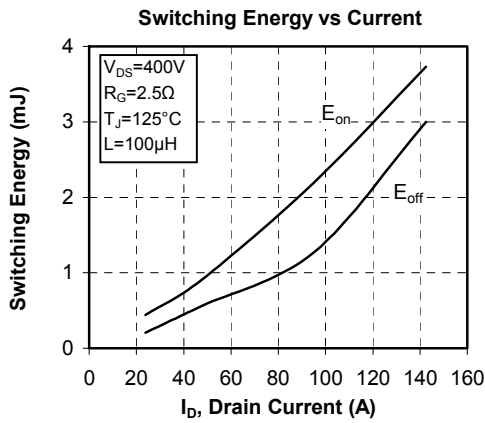
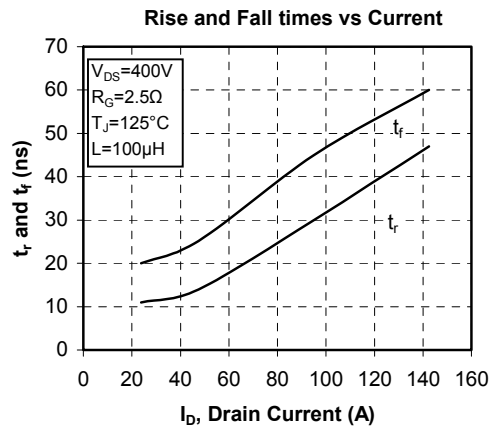
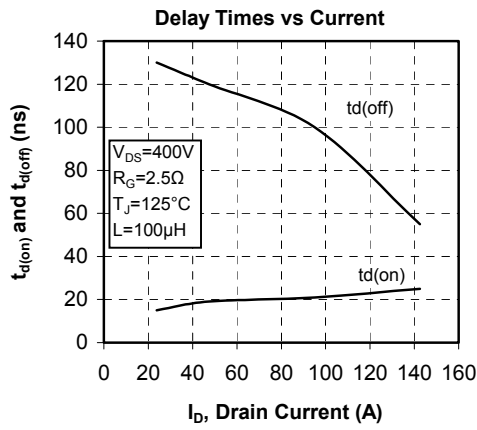
## SP3F Package outline (dimensions in mm)



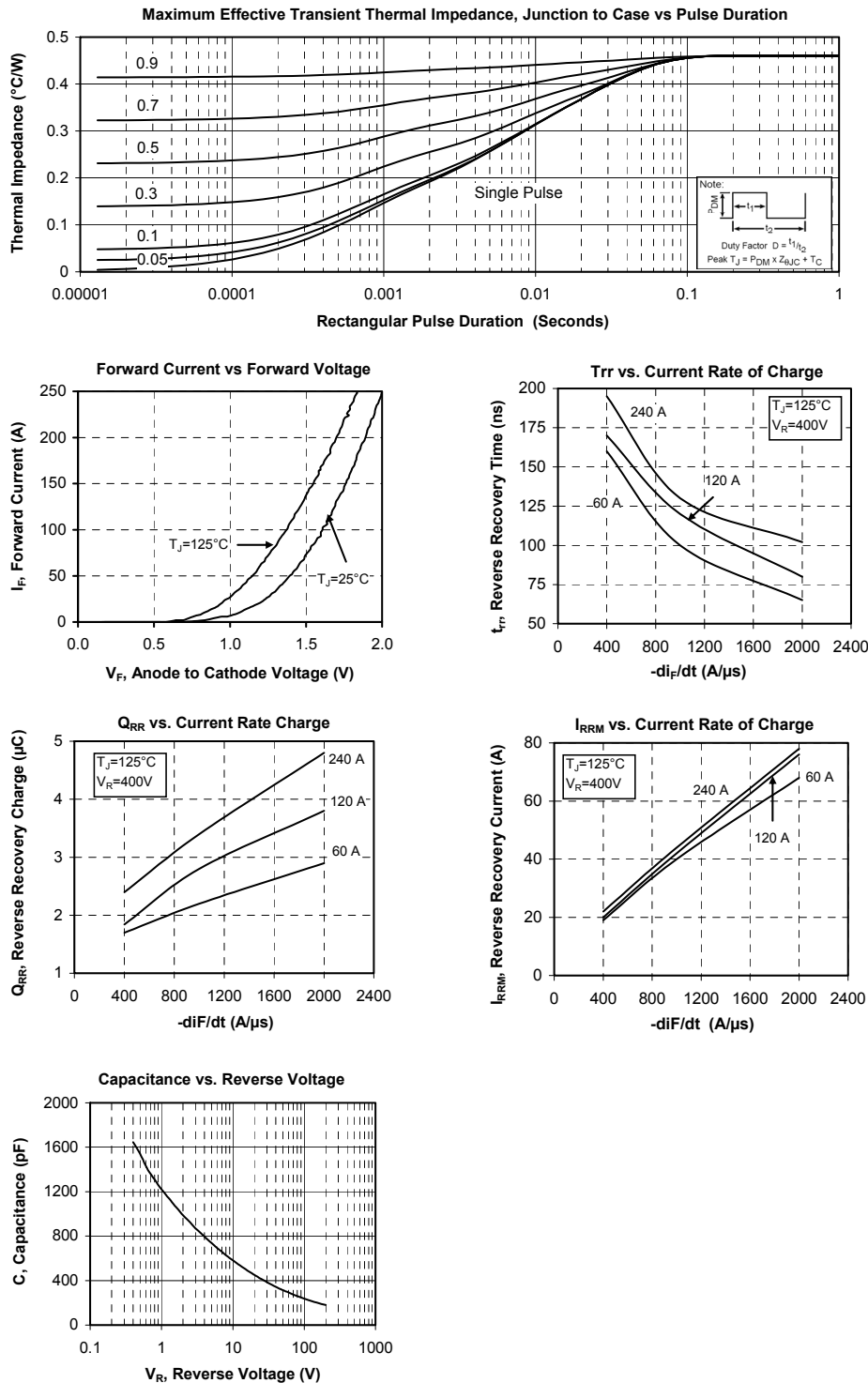
## Typical CoolMOS Performance Curve







## Typical diode performance curves



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